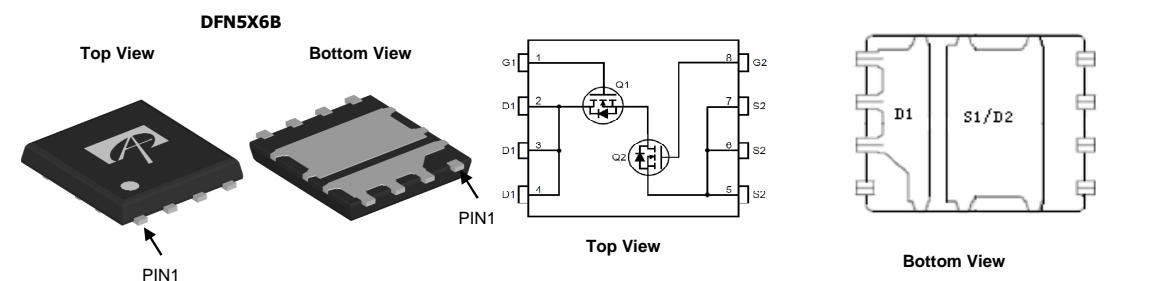


General Description		Product Summary	
• Latest Trench Power AlphaMOS (αMOS LV) technology		<u>Q1</u>	<u>Q2</u>
• Very Low $R_{DS(on)}$ at 4.5V $V_{GS}$		$V_{DS}$	30V
• Low Gate Charge		$I_D$ (at $V_{GS}=10V$ )	16A
• High Current Capability		$R_{DS(ON)}$ (at $V_{GS}=10V$ )	<11.6mΩ
• RoHS and Halogen-Free Compliant		$R_{DS(ON)}$ (at $V_{GS}=4.5V$ )	<17mΩ
<b>Application</b>		100% UIS Tested	
• DC/DC Converters in Computing, Servers, and POL		100% $R_g$ Tested	
• Isolated DC/DC Converters in Telecom and Industrial			


**Absolute Maximum Ratings  $T_A=25^\circ C$  unless otherwise noted**

Parameter	Symbol	Max Q1	Max Q2	Units
Drain-Source Voltage	$V_{DS}$	30		V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	$\pm 20$	V
Continuous Drain Current <sup>G</sup>	$I_D$	16	18	A
$T_C=100^\circ C$		12	14	
Pulsed Drain Current <sup>C</sup>	$I_{DM}$	64	72	
Continuous Drain Current <sup>A</sup>	$I_{DSM}$	14	$18^G$	A
$T_A=70^\circ C$		11.5	14	
Avalanche Current <sup>C</sup>	$I_{AS}$	19	25	A
Avalanche Energy $L=0.05mH$ <sup>C</sup>	$E_{AS}$	9	16	mJ
$V_{DS}$ Spike	100ns	$V_{SPIKE}$	36	V
Power Dissipation <sup>B</sup>	$P_D$	7.3	13	W
$T_C=100^\circ C$		2.9	5.2	
Power Dissipation <sup>A</sup>	$P_{DSM}$	3.5	3.9	W
$T_A=70^\circ C$		2.3	2.5	
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 150		°C

**Thermal Characteristics**

Parameter	Symbol	Typ Q1	Typ Q2	Max Q1	Max Q2	Units
Maximum Junction-to-Ambient <sup>A</sup>	$R_{\theta JA}$	29	26	35	32	°C/W
Maximum Junction-to-Ambient <sup>A,D</sup>		55	50	66	60	°C/W
Maximum Junction-to-Case	$R_{\theta JC}$	13.8	7.7	17	9.5	°C/W

**Q1 Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	30			V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{DS}=30\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$			1 5	$\mu\text{A}$
$I_{\text{GSS}}$	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm20\text{V}$			$\pm100$	nA
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1.2	1.8	2.2	V
$R_{\text{DS(ON)}}$	Static Drain-Source On-Resistance	$V_{GS}=10\text{V}, I_D=13\text{A}$ $T_J=125^\circ\text{C}$	9.6	11.6		$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_D=10\text{A}$	13.4	16.2		$\text{m}\Omega$
$g_{\text{FS}}$	Forward Transconductance	$V_{DS}=5\text{V}, I_D=13\text{A}$	13.6	17		S
$V_{\text{SD}}$	Diode Forward Voltage	$I_S=1\text{A}, V_{GS}=0\text{V}$	0.7	1		V
$I_S$	Maximum Body-Diode Continuous Current				9	A
<b>DYNAMIC PARAMETERS</b>						
$C_{\text{iss}}$	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=15\text{V}, f=1\text{MHz}$		485		pF
$C_{\text{oss}}$	Output Capacitance			235		pF
$C_{\text{rss}}$	Reverse Transfer Capacitance			32		pF
$R_g$	Gate resistance	f=1MHz	0.9	1.8	2.7	$\Omega$
<b>SWITCHING PARAMETERS</b>						
$Q_g(10\text{V})$	Total Gate Charge	$V_{GS}=10\text{V}, V_{DS}=15\text{V}, I_D=13\text{A}$		8	15	nC
$Q_g(4.5\text{V})$	Total Gate Charge			3.9	8	nC
$Q_{\text{gs}}$	Gate Source Charge			1.1		nC
$Q_{\text{gd}}$	Gate Drain Charge			2.1		nC
$t_{\text{D(on)}}$	Turn-On Delay Time	$V_{GS}=10\text{V}, V_{DS}=15\text{V}, R_L=1.2\Omega, R_{\text{GEN}}=3\Omega$		3.5		ns
$t_r$	Turn-On Rise Time			2.8		ns
$t_{\text{D(off)}}$	Turn-Off Delay Time			16.3		ns
$t_f$	Turn-Off Fall Time			3		ns
$t_{\text{rr}}$	Body Diode Reverse Recovery Time	$I_F=13\text{A}, dI/dt=500\text{A}/\mu\text{s}$		9.9		ns
$Q_{\text{rr}}$	Body Diode Reverse Recovery Charge	$I_F=13\text{A}, dI/dt=500\text{A}/\mu\text{s}$		12.9		nC

A. The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The Power dissipation  $P_{\text{DSM}}$  is based on  $R_{\theta JA}$   $t \leq 10\text{s}$  and the maximum allowed junction temperature of  $150^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{J(\text{MAX})}=150^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(\text{MAX})}=150^\circ\text{C}$ . Ratings are based on low frequency and duty cycles to keep initial  $T_J=25^\circ\text{C}$ .

D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.

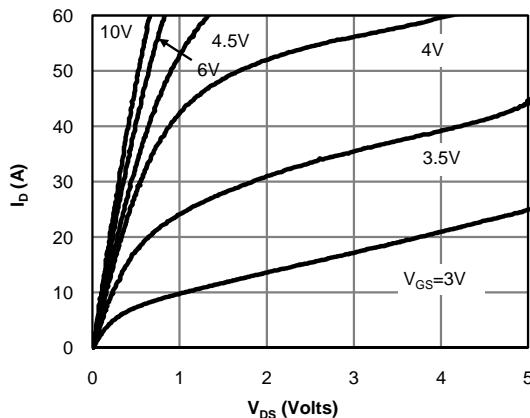
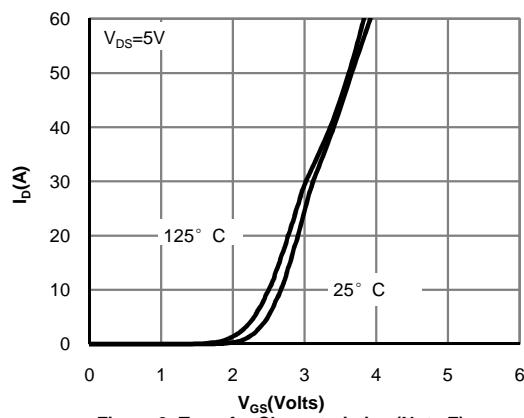
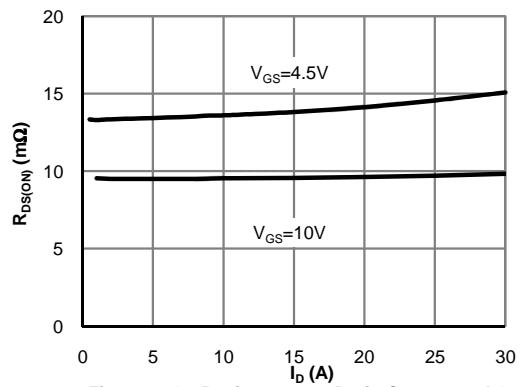
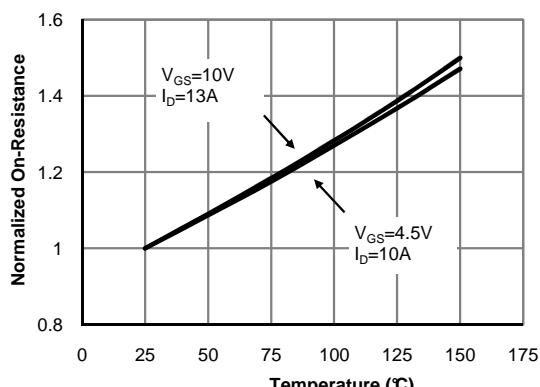
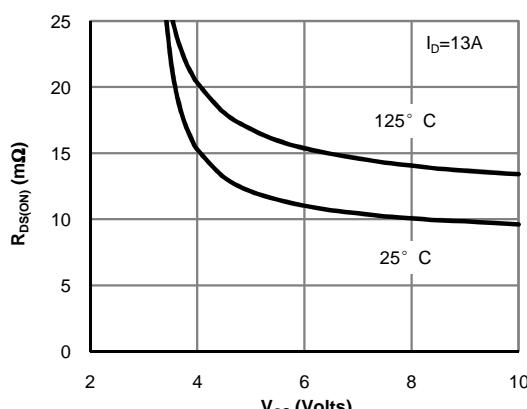
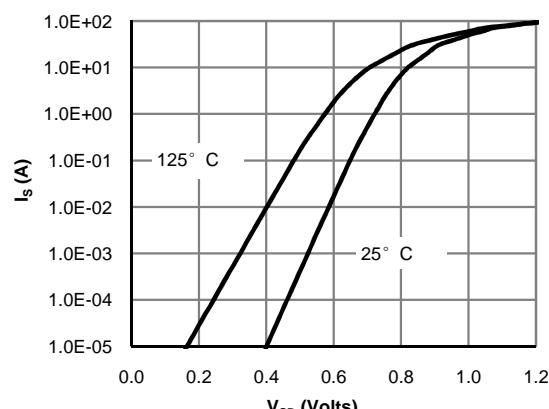
E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

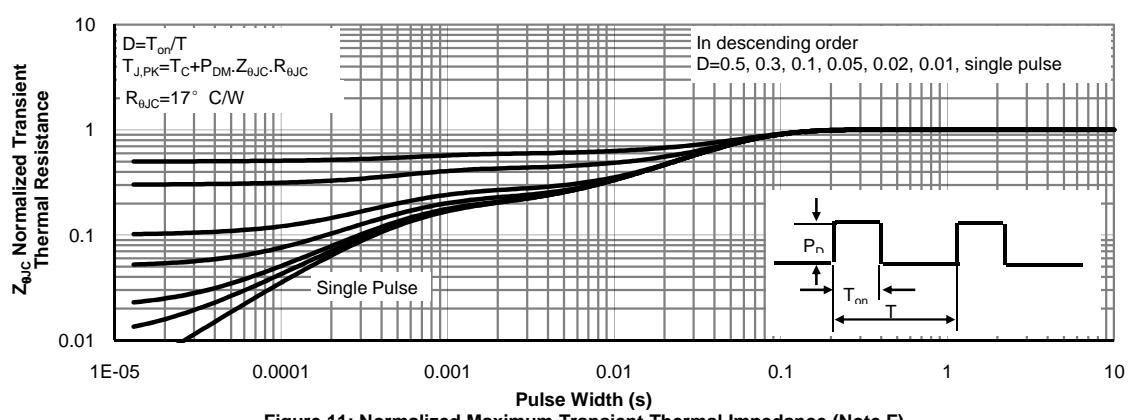
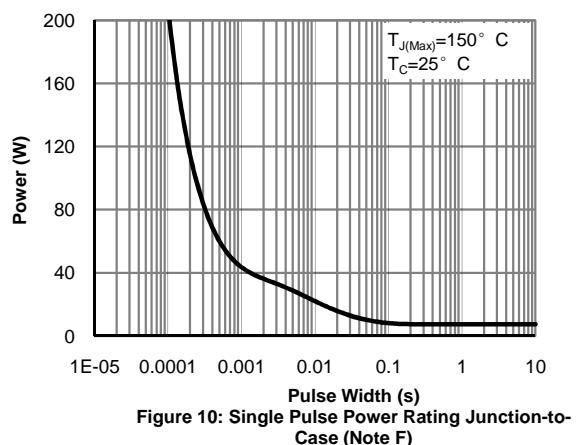
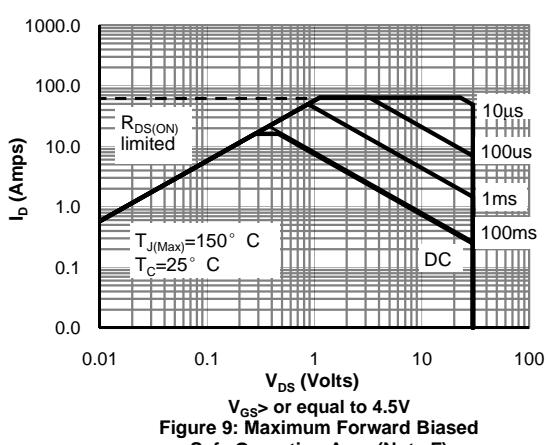
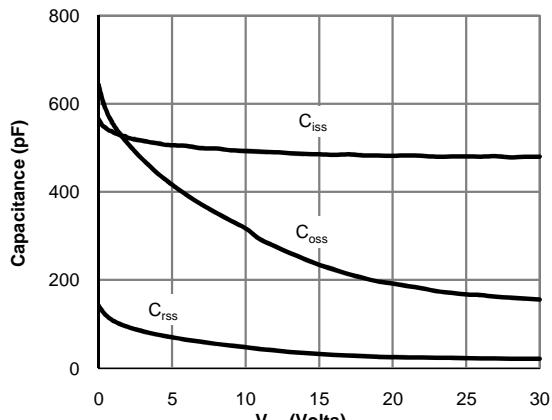
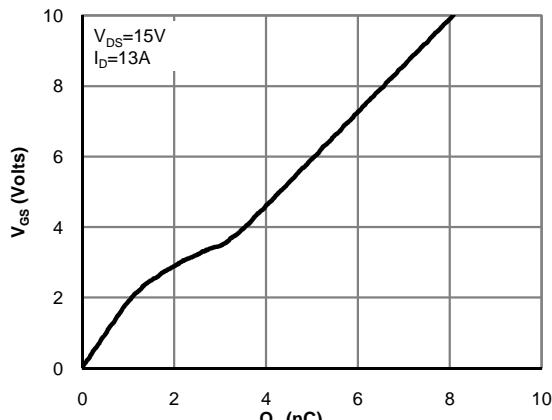
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(\text{MAX})}=150^\circ\text{C}$ . The SOA curve provides a single pulse rating.

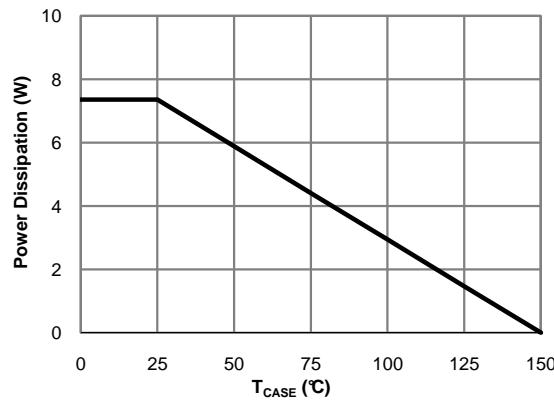
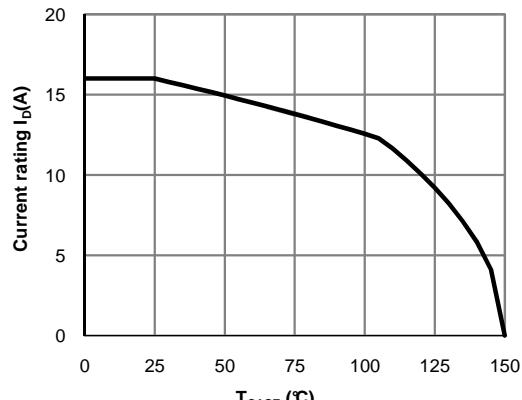
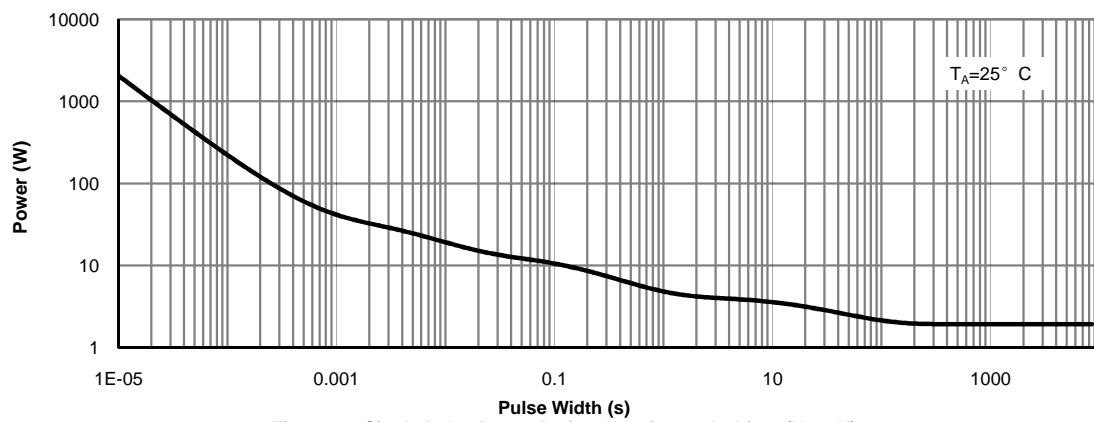
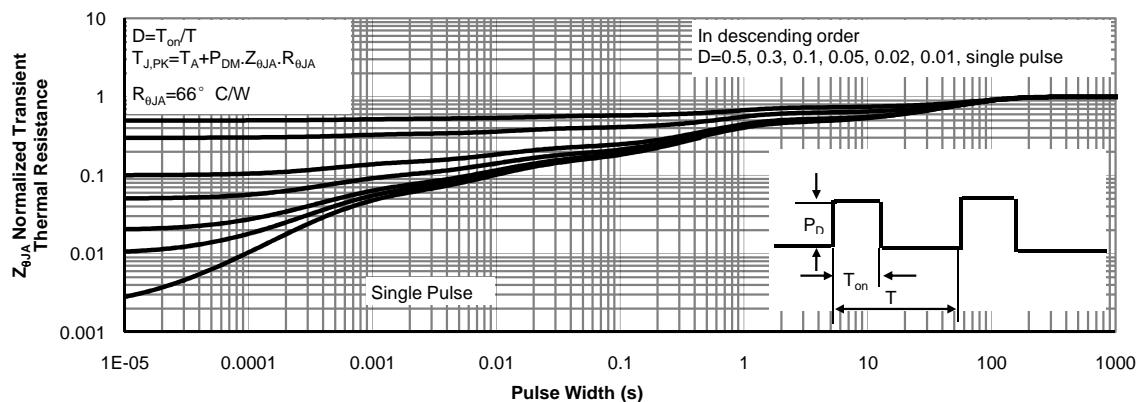
G. The maximum current rating is limited by package.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $TA=25^\circ\text{C}$ .

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**Q1-CHANNEL: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Fig 1: On-Region Characteristics (Note E)**

**Figure 2: Transfer Characteristics (Note E)**

**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**

**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

**Figure 6: Body-Diode Characteristics (Note E)**

**Q1-CHANNEL: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**


**Q1-CHANNEL: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 12: Power De-rating (Note F)**

**Figure 13: Current De-rating (Note F)**

**Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)**

**Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)**

**Q2 Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	30			V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{DS}=30\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$			1 5	$\mu\text{A}$
$I_{\text{GSS}}$	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm20\text{V}$			$\pm100$	nA
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1.2	1.8	2.2	V
$R_{\text{DS(ON)}}$	Static Drain-Source On-Resistance	$V_{GS}=10\text{V}, I_D=15\text{A}$ $T_J=125^\circ\text{C}$	6.5	7.8		$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_D=10\text{A}$	8.8	10.6		$\text{m}\Omega$
$g_{\text{FS}}$	Forward Transconductance	$V_{DS}=5\text{V}, I_D=15\text{A}$	9.4	11.8		S
$V_{\text{SD}}$	Diode Forward Voltage	$I_S=1\text{A}, V_{GS}=0\text{V}$	0.7	1		V
$I_S$	Maximum Body-Diode Continuous Current				15	A
<b>DYNAMIC PARAMETERS</b>						
$C_{\text{iss}}$	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=15\text{V}, f=1\text{MHz}$		807		pF
$C_{\text{oss}}$	Output Capacitance			314		pF
$C_{\text{rss}}$	Reverse Transfer Capacitance			40		pF
$R_g$	Gate resistance	f=1MHz	0.6	1.3	2	$\Omega$
<b>SWITCHING PARAMETERS</b>						
$Q_g(10\text{V})$	Total Gate Charge	$V_{GS}=10\text{V}, V_{DS}=15\text{V}, I_D=15\text{A}$		12.9	20	nC
$Q_g(4.5\text{V})$	Total Gate Charge			6	12	nC
$Q_{\text{gs}}$	Gate Source Charge			2.1		nC
$Q_{\text{gd}}$	Gate Drain Charge			3		nC
$t_{\text{D(on)}}$	Turn-On Delay Time	$V_{GS}=10\text{V}, V_{DS}=15\text{V}, R_L=1\Omega, R_{\text{GEN}}=3\Omega$		4.8		ns
$t_r$	Turn-On Rise Time			3.3		ns
$t_{\text{D(off)}}$	Turn-Off Delay Time			18.8		ns
$t_f$	Turn-Off Fall Time			3.3		ns
$t_{\text{rr}}$	Body Diode Reverse Recovery Time	$I_F=15\text{A}, dI/dt=500\text{A}/\mu\text{s}$		11.3		ns
$Q_{\text{rr}}$	Body Diode Reverse Recovery Charge	$I_F=15\text{A}, dI/dt=500\text{A}/\mu\text{s}$		15		nC

A. The value of  $R_{\text{JJA}}$  is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The Power dissipation  $P_{\text{DSM}}$  is based on  $R_{\text{JJA}} \leq 10\text{s}$  and the maximum allowed junction temperature of  $150^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{J(\text{MAX})}=150^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(\text{MAX})}=150^\circ\text{C}$ . Ratings are based on low frequency and duty cycles to keep initial  $T_J=25^\circ\text{C}$ .

D. The  $R_{\text{JJA}}$  is the sum of the thermal impedance from junction to case  $R_{\text{JJC}}$  and case to ambient.

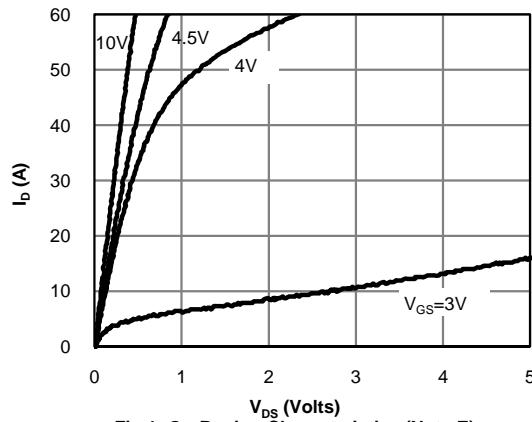
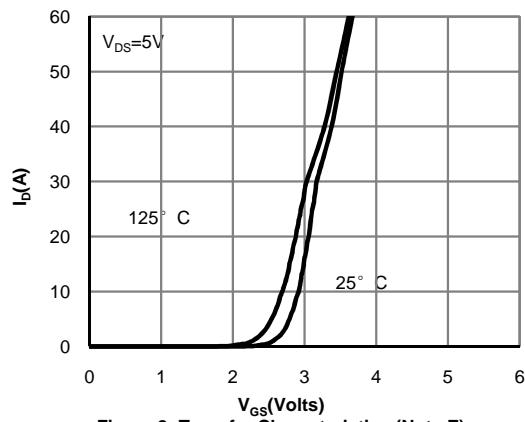
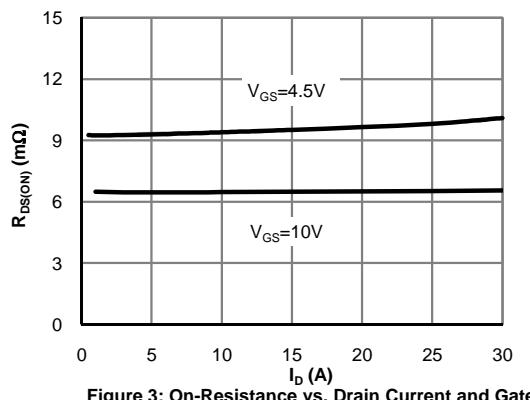
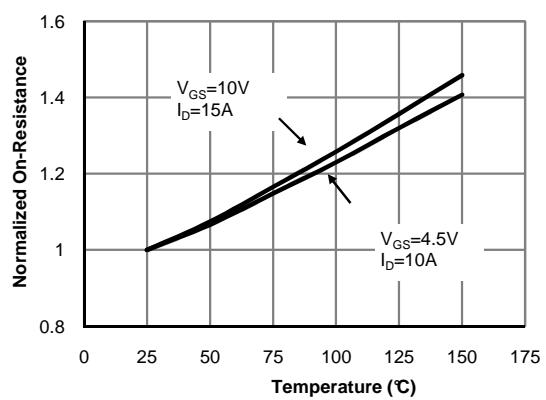
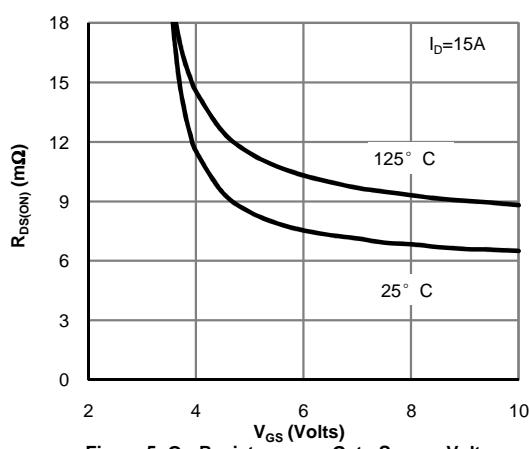
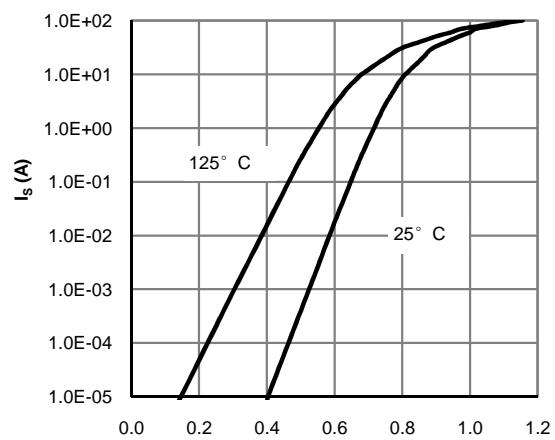
E. The static characteristics in Figures 1 to 6 are obtained using <300 $\mu\text{s}$  pulses, duty cycle 0.5% max.

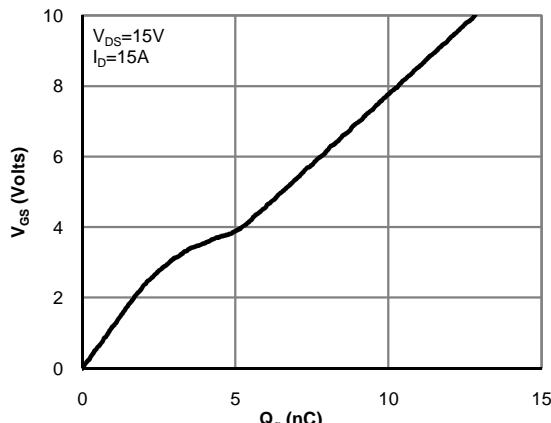
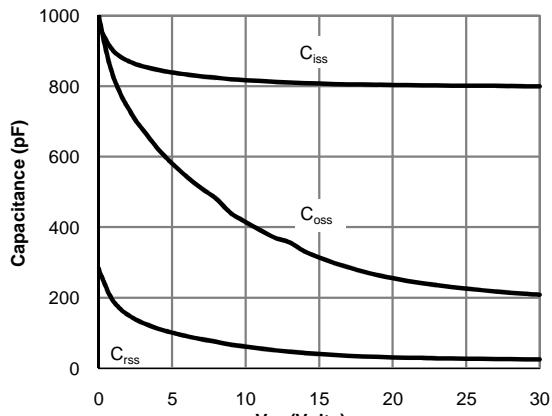
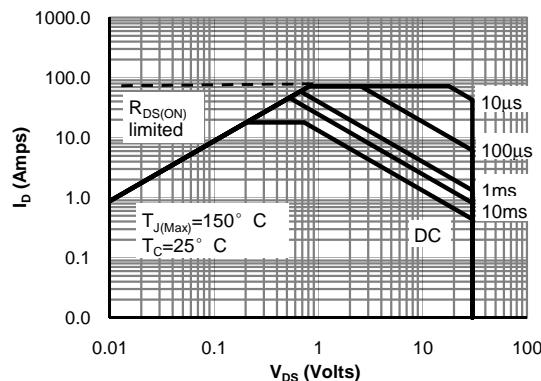
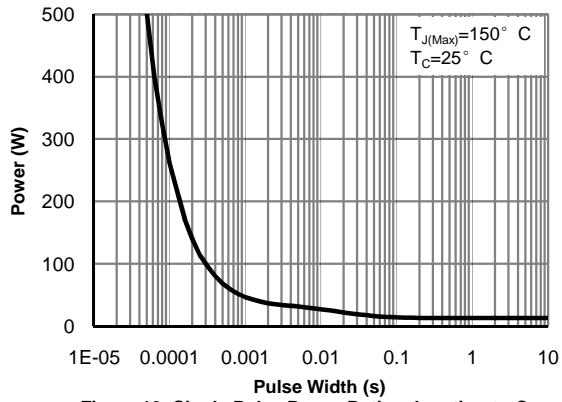
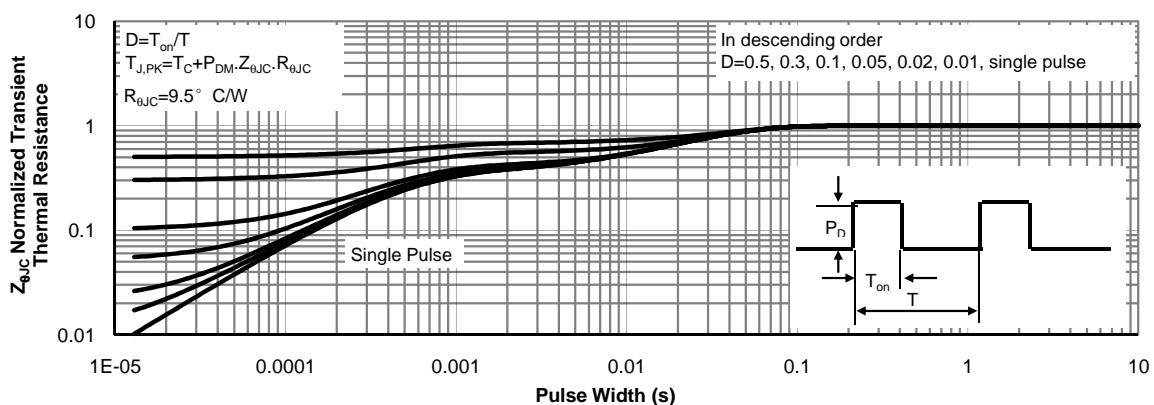
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(\text{MAX})}=150^\circ\text{C}$ . The SOA curve provides a single pulse rating.

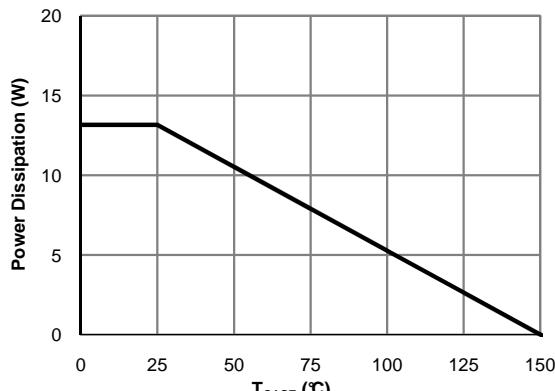
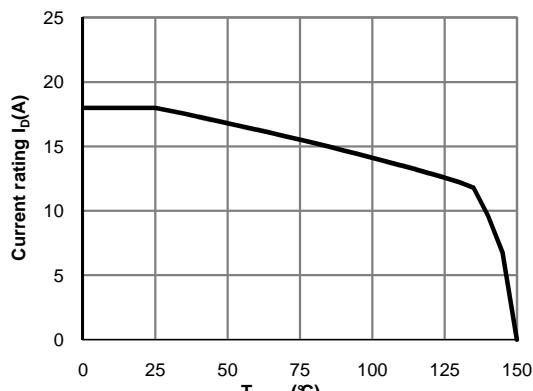
G. The maximum current rating is limited by package.

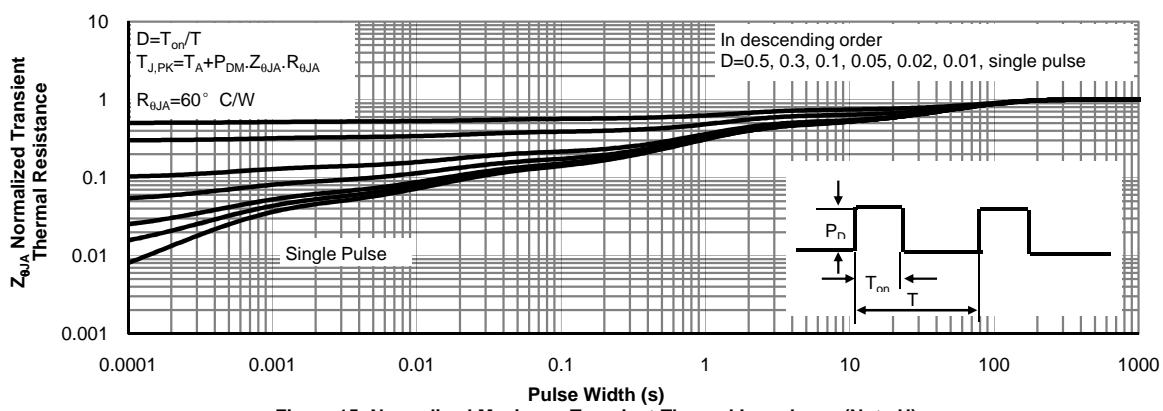
H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ .

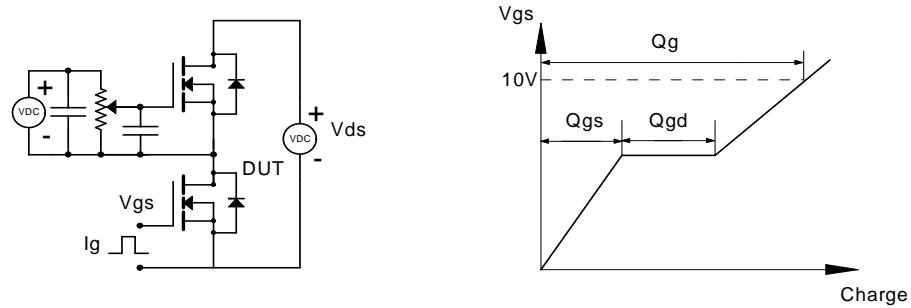
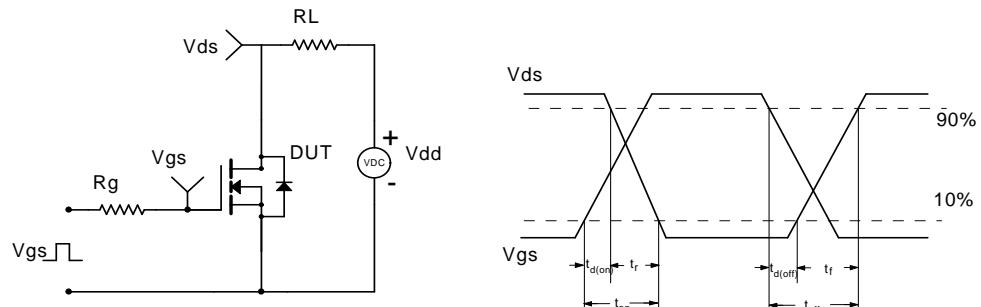
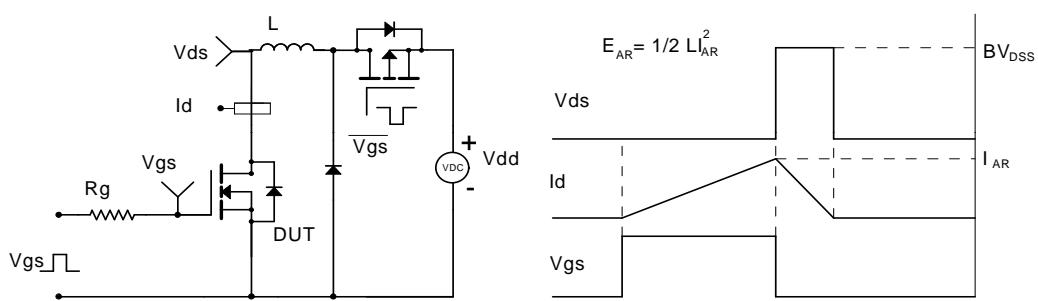
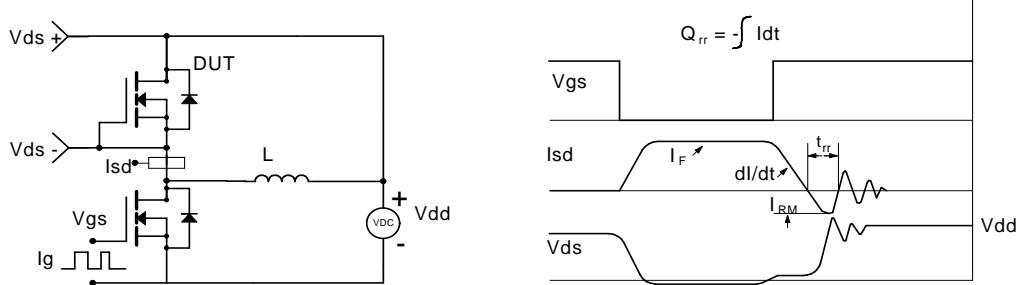
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**Q2-CHANNEL: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Fig 1: On-Region Characteristics (Note E)**

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**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

**Figure 6: Body-Diode Characteristics (Note E)**

**Q2-CHANNEL: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 7: Gate-Charge Characteristics**

**Figure 8: Capacitance Characteristics**

**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**

**Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)**

**Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)**

**Q2-CHANNEL: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 12: Power De-rating (Note F)**

**Figure 13: Current De-rating (Note F)**

**Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)**

**Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)**

**Gate Charge Test Circuit & Waveform**

**Resistive Switching Test Circuit & Waveforms**

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